Search Notes			

	Application/Control No.	Applicant(s)/Patent unde Reexamination	r
	10/708,698	FAN ET AL.	
	Examiner	Art Unit	
-	Quochien B. Vuong	2618	

SEARCHED			
Class	Subclass	Date	Examiner
455	343.1,343. 2 343.4,522	4/17/2006	ar
I	574		1
370	311		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
455	343.4,574	4/17/2006	ar
370	311	(1
PGPUB te	ext search	4/17/2006	ev

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST search	4/17/2006	er	